

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Applicants: Date: February 9, 2010
Beaman et al. Group Art Unit: 2829
Serial No.: 09/251,988 Examiner: J. M. Hollington
Filed: February 17, 1999 Docket No.: YO999-088
For: STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE
POSITION ACCURACY IN A WAFER TEST PROBE ASSEMBLY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

AMENDMENT SUBMITTED WITH RCE

Sir:

This is an amendment submitted with an RCE.

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 5 of this paper.